

Conductivity conversion in CdTe layers

Valdna, Vello; Buschmann, Felix; Mellikov, Enn Journal of crystal growth 1996 / p. 164-167: ill

Influence of point defects on physical qualities of semiconductors

Altosaar, Mare; Buschmann, Felix; Erm, Ants; Krustok, Jüri; Kukk, Peeter-Enn; Lõo, A.; Mädasson, Jaan; Tomson, A. Journal of materials and product. technology 1991

Photometric detectors for chemical control equipment

Buschmann, Felix; Mädasson, Jaan Chair of Semiconductor Materials Technology : activity report, 1988-1993 1994 / p. 27